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	APPLICANT Takashi YOKOKAWA et al.	
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LIST OF REFERENCES CITED BY APPLICANT
(Use several sheets if necessary)

U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<i>swr</i>	AA	2002/0116677	08/22/02	Morelos-Zaragoza			
<i>swr</i>	AB	6,539,367	03/25/03	Blanksby et al.			
	AC						
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	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<i>swr</i>	AL	JP 2004-147318	05/20/04	Japan			
<i>swr</i>	AM	JP 2002-118474	04/19/02	Japan			
<i>swr</i>	AN	JP 2002-33670	01/31/02	Japan			
	AO	EP 1 158 682	11/28/01	Europe			
	AP						

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
	AQ						
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	AS						

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